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**Confirmation Letter** 

To,

Swathi C M

Published in : Volume 2 | Issue 4 | 2015-04-25



Subject: Publication of paper at International Journal of Emerging Technologies and Innovative Research.

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With Greetings we are informing you that your paper has been successfully published in the International Journal of Emerging Technologies and Innovative Research (ISSN: 2349-5162). Following are the details regarding the published paper.

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Thank you very much for publishing your article in JETIR. We would appreciate if you continue your support and keep sharing your knowledge by writing for our journal JETIR.















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